

Correlated Materials Characterization *via* Multimodal Chemical and Functional Imaging

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Abstract

Multimodal chemical imaging simultaneously offers high resolution chemical and physical information with nanoscale, and in select cases atomic resolution. By coupling modalities that collect physical and chemical information, we can address scientific problems in biological systems, battery and fuel cell research, catalysis, pharmaceuticals, photovoltaics, medicine and many others. The combined systems enable local correlation of material properties with chemical makeup, making fundamental questions in how chemistry and structure drive functionality approachable. In this review we present recent progress and offer a perspective for chemical imaging used to characterize a variety of samples by a number of platforms. Specifically, we present cases in infrared and Raman spectroscopies combined with scanning probe microscopy; optical microscopy and mass spectrometry; nonlinear optical microscopy; and finally, ion, electron and probe microscopies with mass spectrometry. We also discuss the challenges associated with the use of data originated by the combinatorial hardware, analysis, and machine learning as well as processing tools necessary for interpretation of multidimensional data acquired from multimodal studies.

Keywords

chemical imaging, data analytics, infrared spectroscopy, raman spectroscopy, scanning probe microscopy, optical microscopy, mass spectrometry, ion microscopy, electron microscopy, nonlinear optical microscopy

Vocabulary

Multimodal chemical imaging – a number of combined independent characterization modalities capable of mapping concentration, or distribution of chemical species.

Functional imaging – characterization techniques for detecting or measuring the distribution of physical parameters.

Generative model - a model of the conditional probability of the observable X , given the target y .

Co-registration – transforming data from multiple sources onto a single common coordinate system.

Data velocity – the speed of data processing.

Acronyms

AFM – Atomic force microscopy

APCI - Atmospheric pressure chemical ionization

ATR - Attenuated total reflection

BE – Band excitation

BE SSPFM - band excitation piezoresponse force microscopy

BF-TEM – Bright field transmission electron microscopy

BMAA - β -N-methylamino-L-alanine

BSE – Backscattered electrons

CARS - Coherent Anti-Stokes Raman Scattering

CNT – Carbon nanotubes

EELS - Electron energy loss spectroscopy

ESI - electrospray ionization

FLIM - Fluorescence Lifetime Imaging Microscopy

FORC - First-order reversal curve

FTIR - Fourier-transform infrared spectroscopy

GCIB - Gas cluster ion beam

GFIS - Gas field ion sources

HIM – Helium ion microscopy

HIPP - High-impact polypropylene

IR - Infrared

IR s-SNOM - Infrared vibrational scattering scanning near-field optical microscopy

LC-MS/MS - Liquid chromatography-tandem mass spectrometry experiments

LMIG - Liquid metal ion guns

MALDI - Matrix-assisted laser desorption/ionization

MALDI-MS - Matrix-assisted laser desorption/ionization mass spectrometry

MALDI-ToF-MSI - Matrix-assisted laser desorption/ionization time of flight mass spectrometry imaging

MCP – Multichannel plate

MRSI - Magnetic resonance spectroscopic imaging

MS – Mass spectrometry

MSI - Mass spectrometry imaging

nc-AFM – Noncontact atomic force microscopy

NP-LDI MS - Nanoparticle assisted laser desorption ionization mass spectrometry

P2VP - Poly(2-vinylpyridine)

P3HT - Poly(3-hexylthiophene-2,5-diyl)

PC – Phosphocholine

PEDOT - Poly(3,4-ethylenedioxythiophene) polystyrene sulfonate

PL – Photoluminescence

PMMA - Poly(methyl methacrylate)

PS - Polystyrene

PTIR - Photo-thermal induced resonance

SEM – Scanning electron microscopy

SFG - Sum-frequency Generation

SHG - Second Harmonic Generation

SIMS - Secondary ion mass spectrometry

SNOM - Scanning near-field optical microscopy

SPM – Scanning probe microscopy

SPM – MS - Scanning probe microscopy mass spectrometry

SRS - Stimulated Raman Scattering

SSPFM - Switching spectroscopy piezoresponse force microscopy

STEM – Scanning transmission electron microscopy

STM – Scanning tunneling microscopy

TAM - Transient absorption microscopy

TEM - Transmission electron microscopy

TERS - Tip-enhanced Raman scattering

TR BE - Time resolved band excitation

TR-PFM - Time resolved piezoresponse force microscopy

The functionality of materials and biological systems from batteries, fuel cells, catalysts, photovoltaics to biological tissues and cells is traditionally studied with macroscopic characterization techniques. However, the underlying functionality is defined by the chemical organization, with characteristic length scales on the order of microns to nanometers. The push towards studying materials and systems at the nanoscale addresses challenges like developing lighter, more energy efficient, economical structural energy materials; as well as understanding biological complexity in a wide range of applications.¹⁻⁵ Current techniques capable of spatially resolving nano- to meso- scale features are limited by the amount of chemical information they offer. For instance, techniques like atomic force microscopy (AFM) with spatial imaging resolution as low as 1 nm provide almost no chemical information.^{6,7} In contrast, chemical imaging approaches can supply chemical information on the molecular level but are not capable of imaging physical properties with high resolution. Therefore, by coupling modalities that collect physical and chemical information, one can begin to address scientific problems using methods tailored to studying systems that require both: nanoscale spatial resolution as well as high chemical specificity. The combined multimodal platforms enable local correlation of material properties with chemical makeup, allowing one to answer fundamental questions in how chemistry and structure of the material drive functionality and physical properties observed on the macroscale.

Here, we review recent progress and offer a perspective for multimodal chemical imaging in characterization of a rich sample spectrum in a correlated manner. We discuss the use of data combinatorial hardware platforms, analysis, as well as machine learning and processing tools that are becoming necessary for interpretation of the multidimensional data acquired from multimodal studies.

Why multimodal imaging?

Understanding the complex functionality of inorganics and ceramics, soft and polymeric materials, and especially biological systems necessitates multiple sources of information, placed in the context of sample history (preparation conditions, medical history, *etc.*) that are related to properties; and likely future behaviors. Correspondingly, published and exploratory studies include multiple characterization and imaging modalities. For example, in solid state chemistry

and materials science the classical characterization approach will include X-Ray, optical and electron microscopy, techniques often performed on the same, or similar sample.⁸⁻¹⁴ The question then arises as to what constitutes multimodal imaging and what are the challenges and benefits of such an approach. Here, we offer a classification of the levels at which multimodal studies can be performed.

As a first class of problems, we consider the case when macroscopic measurements are available along with the imaging data, *i.e.* datasets of the type $R(w)$ and $A(x, y)$, where w is a parameter (*e.g.* wavelength or temperature), and A is the image data. A typical example of these data sets can be X-ray scattering data and optical microscopy. Here, it may be possible to establish the relationship between the data, for example quantify the fraction and number of constituent phases from microscopy, and then use this information to determine identity from scattering. This analysis is generally simple when $R(w)$ is a linear combination of the component spectra and classical linear unmixing methods with known (multiple regression) or unknown endmembers are applicable. For these cases, the statistical methods can establish the uncertainties in the recovered signal, and hence material characteristics. In cases when the signal $R(w)$ has a complex dependence on microstructure (*e.g.* conductivity or dielectric properties), more complex microstructural methods are required and in general this approach is rarely used. Note, that the former problems can be considered as a special class of multimodal imaging for the case where one of the imaging modes has zero resolution.

In the second class of problems we consider the case where the two or more imaging data sets corresponding to dissimilar imaging modalities, $A(x, y)$ and $B(x', y')$ are available, and the spatial grids (x, y) and (x', y') are unrelated. In other words, the imaging is performed at different regions. Where the properties of the sample can be assumed (or are known) to be spatially uniform, the information from $A(x, y)$ and $B(x', y')$ can be compared. For example, observations of the atomic species and point defects at the atomic level can be performed using scanning transmission electron microscopy (STEM), and directly compared to the information on the atomic structure and valence states *via* electron energy loss spectroscopy (EELS). Similar studies can be performed *via* scanning tunneling (STM) and non-contact atomic force microscopy (nc-AFM). However, for bulk materials this approach is more difficult, since STEM visualizes atomic columns (*i.e.* projection of atomic structure on the image plane), whereas STM and nc-AFM are surface sensitive

techniques. Moreover, even for 2D materials such as graphene or layered chalcogenides, simultaneous (or even sequential) imaging of the same region is a very complex problem, due to the difficulties in finding the same area, or possible changes of the surface, and/or the material during sample handling. However, if a sufficiently large body of imaging data on the atomic configurations in both modalities are available, equivalence between the two can be established based on a statistical distribution. Additionally, high-veracity identifiers (*e.g.* defect size) that do not define structure unambiguously, but significantly reduce the number of possible variants can be used. Similarly, for mesoscopic imaging, the average comparison can be performed assuming that readily identifiable characteristics can be used for validation and classification of the structural elements.

The third class of the problems correspond to the case where the data sets $A(x, y)$ and $B(x', y')$ are obtained from the same spatial region, and the grids (x, y) and (x', y') overlap. In this case, the functional properties A and B are explored from (roughly) the same location. In general, the primary initial task of the image analysis workflow becomes the co-registration between the spatial grids, potentially augmented by interpolation, or pan-sharpening to extrapolate the data to a single spatial grid yielding a compound object $[A, B](x'', y'')$. Once such data are available, fundamentally different opportunities to explore and to derive knowledge from the material data open. This can be considered as a full quantifier of dissimilar properties A and B of material, allowing the establishment of a correlative relationship between A and B within the material class. For example, the optical properties can be directly correlated with mass-spectrometric traces, providing the information that can be used to decipher optical measurements.

Finally, the fourth class of the multimodal imaging problems corresponds to a case where the two measurements A and B are spatially incongruent. For example, measurements A are taken on the surface, $A(x, y)$, whereas the measurements B are taken on volume, $B(x, y, z)$. In this case, the natural question is whether the information can be combined. Specifically, can A offer a boundary condition that allows the reconstruction of material properties within the volume B . This class of problems are becoming very common due to the broad propagation of 3D structural mapping tomography tools, and the fact that many physical phenomena including mechanical and ferroelectric are extremely long range and are affected by the boundary conditions as a consequence of generative physics models.

Infrared and Raman Spectroscopies with Scanning Probe Microscopy

Infrared (IR) spectroscopy is commonly used to characterize bulk chemical composition, based on the infrared light interaction with matter *via* absorption or emission. Raman spectroscopy, which is based on inelastic scattering of monochromatic light in visible, near infrared or near ultraviolet range, is another powerful optical technique used for chemical mapping of materials. Raman and IR spectroscopies offer information on chemical bonds and local chemical environments based on the spectroscopic signatures recorded. While powerful, these conventional instruments are averaged over an ensemble of molecular species, thus providing an average description of local chemistry. Adaptation of these approaches to microscopic platforms provides an avenue to map chemical signatures in a spatially resolved manner, but are intrinsically limited by the diffraction limit to modest spatial resolutions of $\sim 2.5\text{-}75\ \mu\text{m}$ and $\sim 0.25\text{-}1\ \mu\text{m}$ for IR and Raman microscopes, respectively.^{15, 16}

However, collecting infrared spectra with high spatial resolution and visualizing the spatial distribution of chemical properties, or functional groups would provide useful insights hitherto inaccessible with a classical set-up. This type of a study can be based on the absorption of light by matter, and the local excitation of molecular vibrations. The vibrational frequencies of these types of transitions are defined by the chemical surroundings, allowing to match the experimentally observed peaks with certain chemical regions. Large volumes of the peak-group assignments have been tabulated, making infrared spectroscopy a reliable technique for chemical analysis in a variety of areas such as organic chemistry,¹⁷ inorganic chemistry,¹⁸ industrial process control¹⁹ and sensors.²⁰ Moreover, the peak shape can indicate changes in the molecular conformation and orientation,²¹ to reveal thermodynamic properties,²² as well as the defect formation.²³ Thus, tracking specific peaks, or collecting spectra on a spatially dense grid can image chemical properties in areas of interest and surroundings. One of the most promising ways to overcome the diffraction limit in spatial mapping, and obtain high-resolution local chemical maps, is to combine atomic force microscopy (AFM) with optical spectroscopy.²⁴ Adhesion and elastic modulus can be overlaid with chemical maps highlighting interplay between crystallinity, composition, and intermolecular interaction between and within single domains. Combined infrared vibrational scattering scanning near-field optical microscopy (IR s-SNOM) with force–distance spectroscopy

can also be used for simultaneous characterization of both nanoscale optical and nanomechanical molecular properties.²⁵ (**Figure 1**).

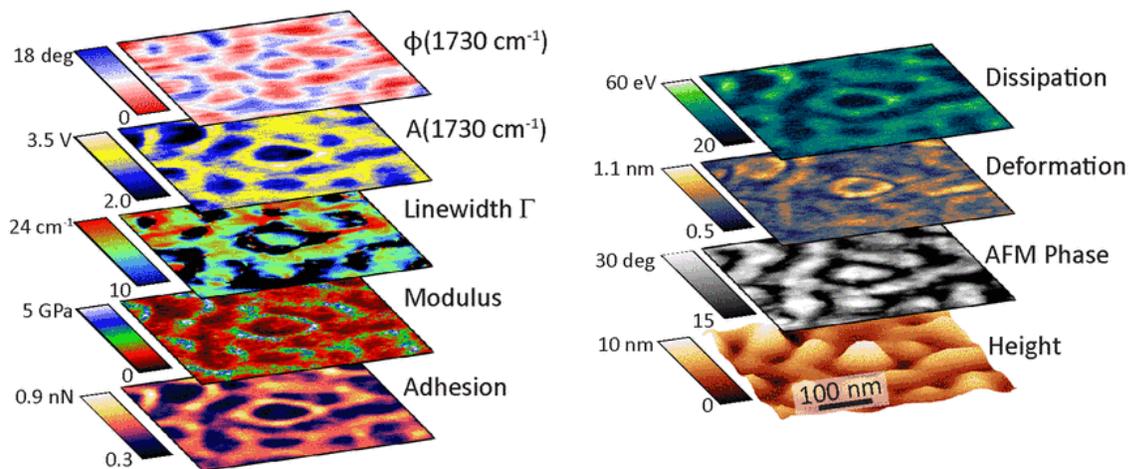


Figure 1. Multidimensional dataset showing maps of PS and PMMA microdomains. Adopted with permission from 25 under the Creative Commons Attribution License subject to the Beilstein Journal of Nanotechnology terms and conditions 2018.

Additionally, the AFM probe can be used as a detector and capture light interactions with matter down to ~ 10 nanometers. Using near-field effects, scanning near-field optical microscopes (SNOM) have become popular; with aperture- and aperture-less versions commercially available. Raman²⁶ and Nanoscale IR^{27, 28} with signal amplified by the scanning probe have demonstrated the potential of nanoscale chemical signal acquisition. In tip-enhanced Raman scattering (TERS)²⁹ the intrinsically low intensity of Raman scattering is successfully overcome³⁰ with near-field amplification by plasmonic and chemical enhancements. As a result, TERS finds³¹ its applications in imaging of graphene,³² polymers,^{33, 34} silicon-based structures,³⁵ semiconductors^{36, 37} as well as biological systems.³⁸ Sub-nanometer resolution chemical images have been demonstrated recently³⁹ (**Figure 2**). However experimental parameters may alter the Raman spectra qualitatively and quantitatively by *e.g.* the pressure applied to the tip, and distance to the species being probed

which complicates the analysis of the data.⁴⁰

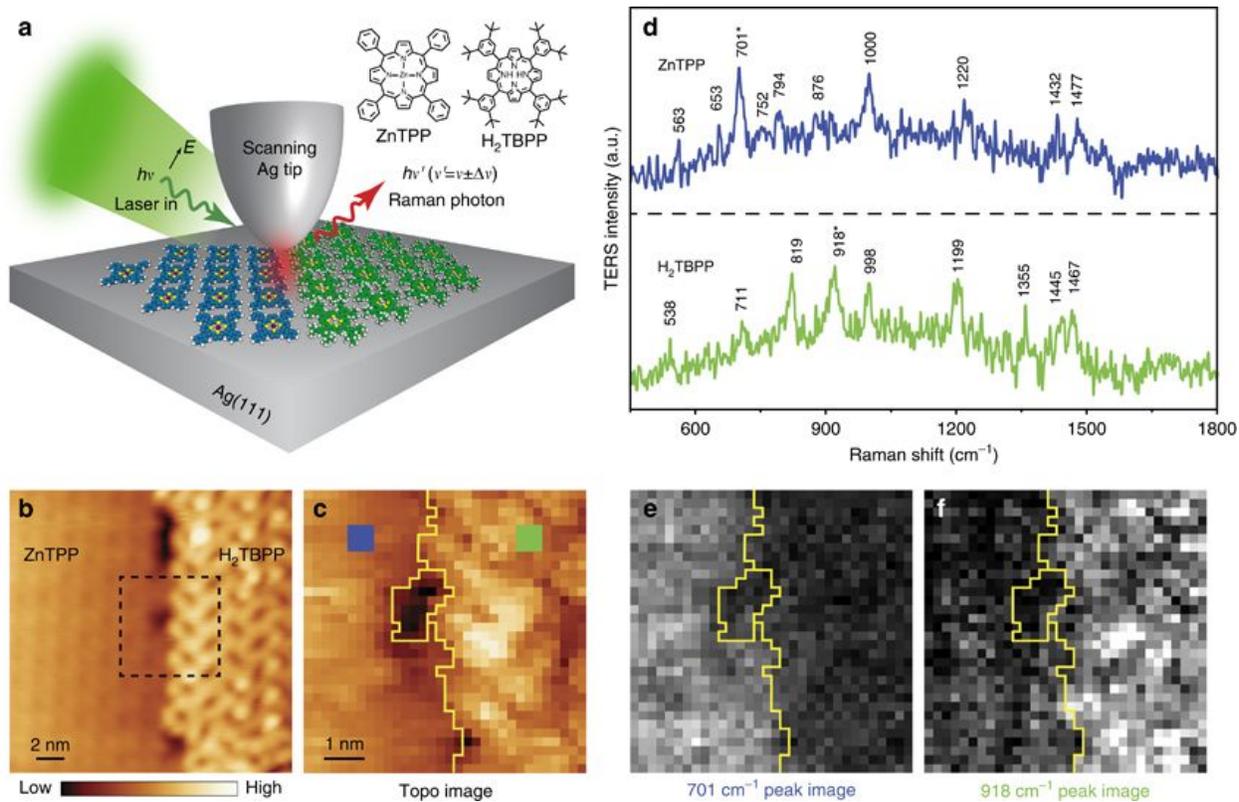


Figure 2. TERS imaging of molecular domains adsorbed at silver terraces. (a) Schematic of STM-controlled TERS. The molecular structures of the porphyrin molecules under study (ZnTPP and H₂TBPP) are shown in the upper-right corner. (b) STM image of two adjacent porphyrin molecular domains (−1 V, 5 pA). (c) STM image simultaneously acquired during TERS imaging of the area denoted by the dashed square in b (−0.1 V, 1 nA, 7 × 7 nm², 32 × 32 pixels, 1 s per pixel). The boundary between the molecular domains is highlighted by a yellow line. (d) TERS spectra, averaged over the blue and green squares (3 × 3 pixels) shown in c, extracted from the datacube for ZnTPP and H₂TBPP molecules, respectively. (e, f) TERS images reconstructed based on single-peak analysis for the Raman peaks at ~701 cm⁻¹ (e, integrated over 687–736 cm⁻¹) and ~918 cm⁻¹ (f, integrated over 890–959 cm⁻¹). Adopted with permission from 39 under a Creative Commons Attribution-NonCommercial-ShareAlike 4.0 International License, Nature 2018.

By tuning an IR laser across a spectral region and measuring the deflection of the cantilever, one can generate a vibrational spectrum that matches those measured by conventional attenuated total reflection (ATR) Fourier-transform infrared spectroscopy (FTIR) instruments but is spatially resolved. This approach can also be used more generally with light outside of IR region which is referred to as photo-thermal induced resonance (PTIR). Traditionally, the IR evanescent field in a

total internal reflection geometry has been used to induce thermal expansion of the sample. In practice this is limited by the availability of the ATR crystals as substrates. To resolve this issue, in more modern set-ups infrared light is introduced from the side, which allows the any thermally conductive substrate for sample to be used. Next major improvement was in the resonant signal enhancement.⁴¹ Here, the excitation rate of the quantum cascade laser is tuned to match the contact resonance of the scanning probe. Deposits as thin as 4 nm can be analyzed using this approach. With AFM cantilever resonance enhancement, it is possible to conduct IR measurement in liquid environment as contact resonances of higher cantilever modes are less dampened.⁴² In addition, tapping mode AFM-IR has been developed by Anasys to for characterization of soft matter, which suffer from the physical contact between the sample and scanning probe. Another intriguing approach involving substitution of the conventional AFM tip with microscale optical transducers has been recently demonstrated⁴³ offering drastic improvement of the signal-to-noise ratio. Additional improvements also include light polarization control.⁴⁴

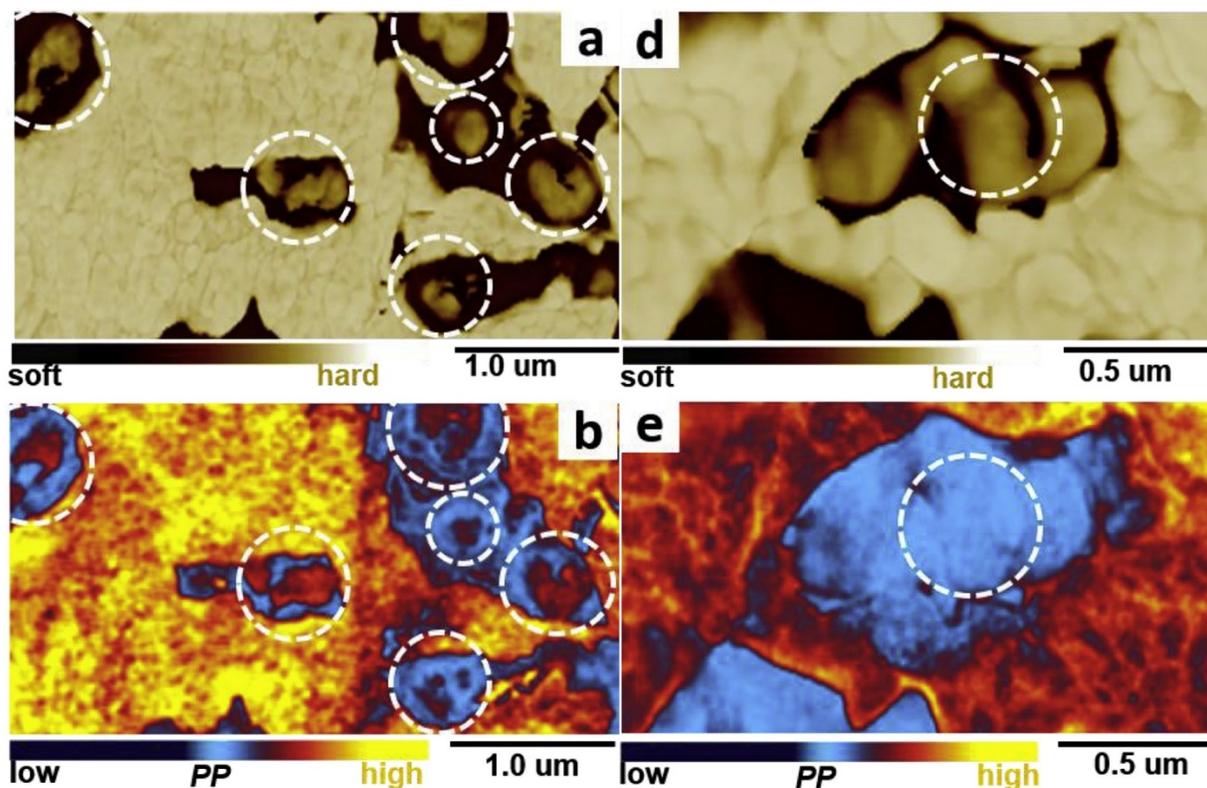


Figure 3. Two samples of high-impact polypropylene (HIPP): AFM phase images of (a, d), AFM-IR absorption maps at 974 cm^{-1} (b, e), where warmer color stands for stronger absorption and higher polypropylene content. Left column (a, b) for HIPP-1, and right column (d, e) for HIPP-2. In HIPP-1, the rigid cores of the particles are rich in polypropylene, which is highly crystalline, whereas for HIPP-2, the major component of the rigid cores is polyethylene with a high degree of crystallinity. The formation of these very different structures and compositions in the core and rubber domains may be attributed to different chain structures and compositions of the copolymers in the alloys produced by different catalysts. Reprinted from 45, Tang, F. G.; Bao, P. T.; Roy, A.; Wang, Y. X.; Su, Z. H., In-Situ Spectroscopic and Thermal Analyses of Phase Domains in High-Impact Polypropylene. *Polymer* **2018**, *142*, 155-163 with permission from Elsevier.

The analysis of polymer blends⁴⁶ and nanocomposites⁴⁷ is a well-suited application for AFM-IR. For example, it is possible to investigate the internal structure of polymer blends; while the phase image of two high-impact polypropylene samples show similar internal structure of the multilayer rubber particles, the AFM-IR reveals that the chemical distribution is very different. (**Figure 3**). Quantitative analysis of nanodomains in polymer-based materials that relates chemical composition and localized thermal properties can be carried out using this approach.^{45, 48} AFM-IR has been used to confirm the uniformity of the polymerization reaction of PEDOT⁴⁹ and P3HT.⁵⁰ CNT-reinforced thermoset composites have been investigated revealing the distribution of chemical interfaces.⁵¹ The sensitivity levels allow the characterization of additive migration in the industrial samples.^{41, 52} Finally, it is possible to perform AFM-IR measurements on biological samples such as cells⁵³⁻⁵⁵ and tissue⁵⁶ without staining. The development of cataract in human lenses has been recently characterized with AFM-IR⁵⁷ revealing the differences in protein secondary structure between clear and opaque lens samples. As the infrared spectra is sensitive to molecular vibrations, the distribution of the organic species in the hybrid materials such as methylammonium lead halides can be clearly observed.⁵⁸ The direct registration of the local chemical changes generates an additional channel of information that aids the electrical characterization of samples and opens perspectives on the electromigration.

Optical Microscopy and Mass Spectrometry

Multimodal chemical imaging techniques coupled with mass spectrometry has a particularly bright future in the biomedical and biological sciences. Although single mode imaging is well-established in many scientific sub-fields, the combination of various complementary imaging modes – offering

correlated information is still only emerging. These studies typically involve an optical imaging technique combined with a mass spectrometry technique, or a combination of various mass spectrometric modalities that are intrinsically complementary. As the complexity of the system under study increases, as is the case with biological systems, the value added by each imaging mode becomes increasingly more evident. The capability to detect highly diverse molecules found in biological specimens benefits from the various types of imaging modes, where one mode can detect species undetectable by another.⁵⁹ Combination of nanoscale infrared spectroscopy and mass spectrometry allows to circumvent some limitations imposed by either techniques used alone (**Figure 4**). For example, while AFM-IR images have higher resolution, the sampling depth of is a complex function of tip temperature, scanning parameters (*e.g.*, scan speed), and heat transfer of the surface. By including mass spectrometry data into analysis it is possible to highlight the chemical composition of the surface.

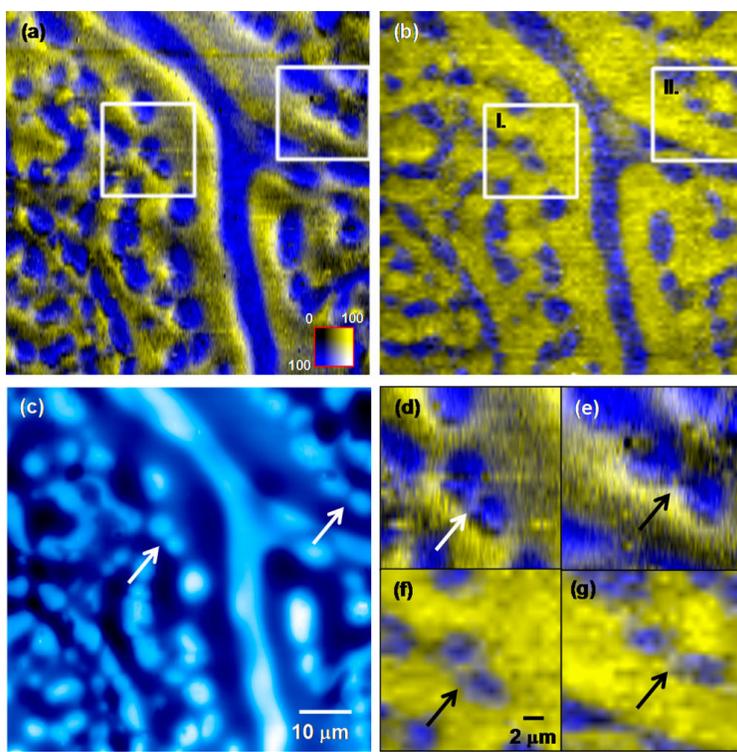


Figure 4. (a) 2D IR and (b) 2D MS chemical images for PMMA and P2VP, as well as (c) the related 2D topography image. Zoomed-in regions of (d, e) IR and (f, g) MS chemical images shown in (a) and (b) corresponding to areas I and II, respectively, indicated by the white squares in the full-size images. Arrows indicate about 1.6 μm wide gaps between PMMA features that are visible in the images in (c–g). Adopted with permission from 60, Tai, T.; Karacsony, O.; Bocharova, V.; Van Berkel, G. J.; Kertesz, V., Topographical and Chemical Imaging of a Phase Separated Polymer

Using a Combined Atomic Force Microscopy/Infrared Spectroscopy/Mass Spectrometry Platform. *Anal. Chem.* 2016, 88, 2864-2870. Copyright (2018) American Chemical Society.

Significant challenges in terms of imaging data analytics are still pervasive. These challenges scale with the complexity of the system and become more significant as instrumentation is refined, and both spatial and spectral resolution increase. With this trend, data density for each imaging mode becomes increasingly difficult to manage. For example, latest generation of matrix-assisted laser desorption/ionization time of flight mass spectrometry imaging (MALDI-ToF-MSI) instruments are now capable of acquiring spectra at a rate of 50 pixels s⁻¹ by combining high repetition-rate lasers, synchronized with fast-moving sample stages, feeding into hardware that can sustain high data write speed.⁶¹ These experiments can generate data files on the order of TBs per sample; resolved at 50 μm², containing ~10 million individual spectra.

Another significant challenge is *in-situ* real-time molecular identification of biochemical species, essential for mapping molecules in biochemical pathways and understanding their larger biological impact. In the case of proteins, original approaches for spatially-targeted liquid micro-extractions,⁶² spatial extractions coupled to label-free liquid chromatography tandem mass spectrometry experiments,⁶³ *in-situ* tryptic digestion,⁶⁴ and in-source decay experiments,⁶⁵ among others are being developed. In the case of small molecules – metabolites and lipids, molecular identification relies heavily on high resolution mass analyzers combined with tandem MS experiments.⁶⁶ The lack of retention time information, as with chromatographic experiments, and the fragmentation of metabolomics databases, are some of the remaining challenges that prevent real-time identification of metabolites and lipids during mass spectrometry imaging (MSI) experiments.^{67, 68}

Various MS approaches have been utilized in a multimodal environment combined with orthogonal analytical methodologies for biomedical applications. Sweedler *et al.* were some of the first teams to combine secondary ion mass spectrometry (SIMS) and matrix-assisted laser desorption/ionization mass spectrometry (MALDI MS) for the purposes of imaging rat spinal cord tissue sections. This multimodal approach enhanced the chemical coverage of the MSI experiment, revealing molecular properties of the chemically-diverse but anatomically-discrete motor and sensory cell networks.⁶⁹ Phospholipids, proteins and neuropeptide distributions were obtained from single 20 μm² sections. Analyte identities were preliminary assigned by mass-to-charge ratio

matches, followed by liquid chromatography-tandem mass spectrometry experiments (LC-MS/MS). Later work also combined SIMS and MALDI, but in a hybrid, single ion source design,⁷⁰ enabling ion images of individual invertebrate neurons, mammalian spinal cord, and cultured neural networks (**Figure 5**). Confocal Raman microscopy coupled to SIMS and registered *via* an array of chemical microdroplets was later used for imaging quinolone signaling molecules in *P. aeruginosa* biofilms, important in human diseases such as cystic fibrosis and in bacterial ecology studies.^{71, 72}

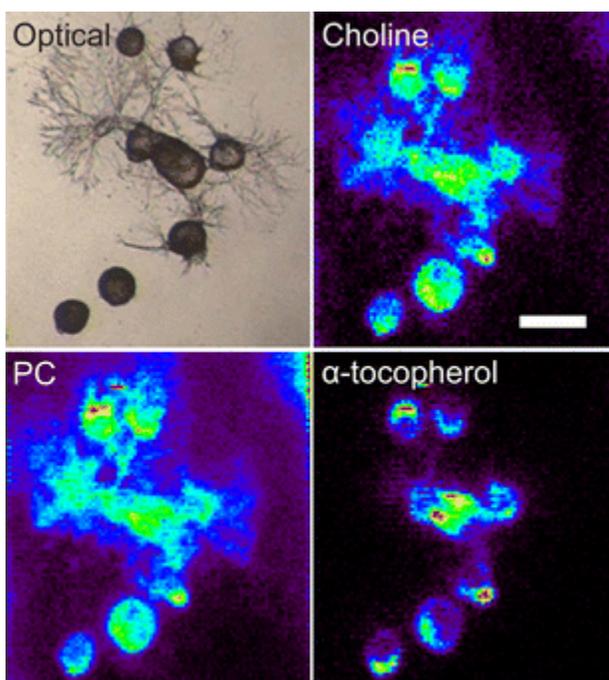


Figure 5: C₆₀ SIMS images of an *A. californica* neural network obtained with a hybrid SIMS/MALDI ion source coupled to a commercial quadrupole-time of flight mass spectrometer allowing both high resolution and tandem MS measurements directly from biological specimens. PC=phosphocholine. The scale bar corresponds to 200 μ. Reproduced by permission from Springer Nature reference 70, Lanni, E. J.; Dunham, S. J. B.; Nemes, P.; Rubakhin, S. S.; Sweedler, J. V., Biomolecular Imaging with a C60-Sims/Maldi Dual Ion Source Hybrid Mass Spectrometer: Instrumentation, Matrix Enhancement, and Single Cell Analysis. *J. Am. Soc. Mass Spectrom.* 2014, 25, 1897-1907.

Pioneering work by Heeren *et al.* demonstrated the combined application of magnetic resonance spectroscopic imaging (MRSI), metal-assisted SIMS, matrix enhanced SIMS, and MALDI MS for *in vivo* and *ex vivo* measurements on metastatic and non-metastatic breast cancer xenograft models⁷³. Principal component analysis of the multimodal imaging data revealed distinct tumor

microenvironments characterized by their characteristic molecular signatures, revealing the altered choline metabolism and transport characteristic of cancer cells. Multimodal imaging can also be performed in a two-step fashion, with the sampling event separated in space and time from the detection event. The combination of laser capture microdissection with continuous on-line atmospheric pressure chemical ionization mass spectrometry enabled the sampling event to take place at higher resolution than typical for most MS imaging approaches (a few to sub-micron), whereas the detection was provided by downstream thermal vaporization of the generated tissue aerosols and reaction with an atmospheric pressure plasma leading to proton transfer and mass spectrometric detection.⁷⁴

Multimodal imaging MS has also been successfully used in several other biological applications. Ewing *et al.* employed multimodal imaging *via* time of flight secondary ionization mass spectrometry (ToF-SIMS) and MALDI MS to investigate spatial distributions of the environmental toxin β -N-methylamino-L-alanine (BMAA) in hippocampus sections of a rat. BMAA has been causatively linked to neurodegenerative disease pathology and, in a rat model, learning and memory impairments.⁷⁴ More recent work has demonstrated the simultaneous imaging of both N-glycans and proteins in the same tissue section *via* MALDI MSI.⁷⁵ Using a single technique, but two sequential on-tissue digestion procedures with PNGaseF and trypsin, complementary images on leiomyosarcomas, myxoid liposarcomas, and colorectal carcinoma tissues were produced. Fixed adrenal cells prepared for and imaged by transmission electron microscopy were also imaged by both ToF-SIMS and nanoSIMS.⁷⁶ Ewing *et al.* have recently demonstrated the multimodal use of nanoparticle assisted laser desorption ionization mass spectrometry (NP-LDI MS), MALDI MS, and gas cluster ion beam (GCIB) SIMS to investigate intact lipids in mouse brain tissues.⁷⁷ GCIB SIMS acts as a semi-soft ionization method that closes the gap between conventional SIMS and MALDI techniques in terms of internal energy deposition and ion fragmentation. More recently, a “trimodal” MALDI MSI approach imaging positive and negative lipids and proteins at a resolution of 10 μ m was reported, revealing spatially correlated lipid and peptide distributions involved in A β plaque pathology in Alzheimer’s disease.⁷⁸

The aforementioned body of work and its success in utilizing multi-modal imaging techniques in mass spectrometry, are just a sliver of a growing community reliant on these and similar tools to advance research across a wide biomedical front. It is expected that the number of tools and

researchers utilizing these approaches will continue to grow with techniques increasing in complexity and in produced data. Some of the complexity alone stems from higher resolution mass spectrometry techniques operating at nanoscale, and coupled with scanning probe microscopy techniques, described in the next section.

Ion, Electron and Probe Microscopy with Mass Spectrometry

In the last few decades a whole class of MSI techniques was developed to map distribution of the chemical composition with spatial resolution ranged from nanometers to tens of microns.⁷⁹⁻⁸³ Here, the surface and the sub-surface chemistry of the sample is analyzed *via* a focused physical probe (ionic, optical, thermal, *etc.*), which releases the analyte species from a small area on the sample. The specific probes define the *pros* and the *cons* of a given technique. For instance, ionic probes used in SIMS allow chemical imaging with sub-micron spatial resolution,^{84, 85} but lead to significant fragmentation of large molecules,⁸⁶ complicating data interpretation in biological and polymeric systems. On the other hand, optical probes (MALDI) and discussed at some length in the previous section,⁸⁷ allow direct identification of large molecules (*e.g.* lipids, peptides and proteins),⁸⁸⁻⁹¹ but requires an appropriate matrix and suffer from low spatial resolution, limited by the size of laser beam; down to few micrometers. Released secondary species in MSI are further analyzed using different types of the mass detectors (time-of-flight, magnetic sector, orbitrap, *etc.*) to acquire information on the local chemical composition at a certain spatial point on the surface. Rastering the beam/probe thus produces chemical maps, containing information on the distribution of chemical species. When the electron microscopy signal is combined with secondary ion spectroscopy, high resolution imaging is supplemented by the chemical sensitivity intrinsic to MS **(Figure 6)**.

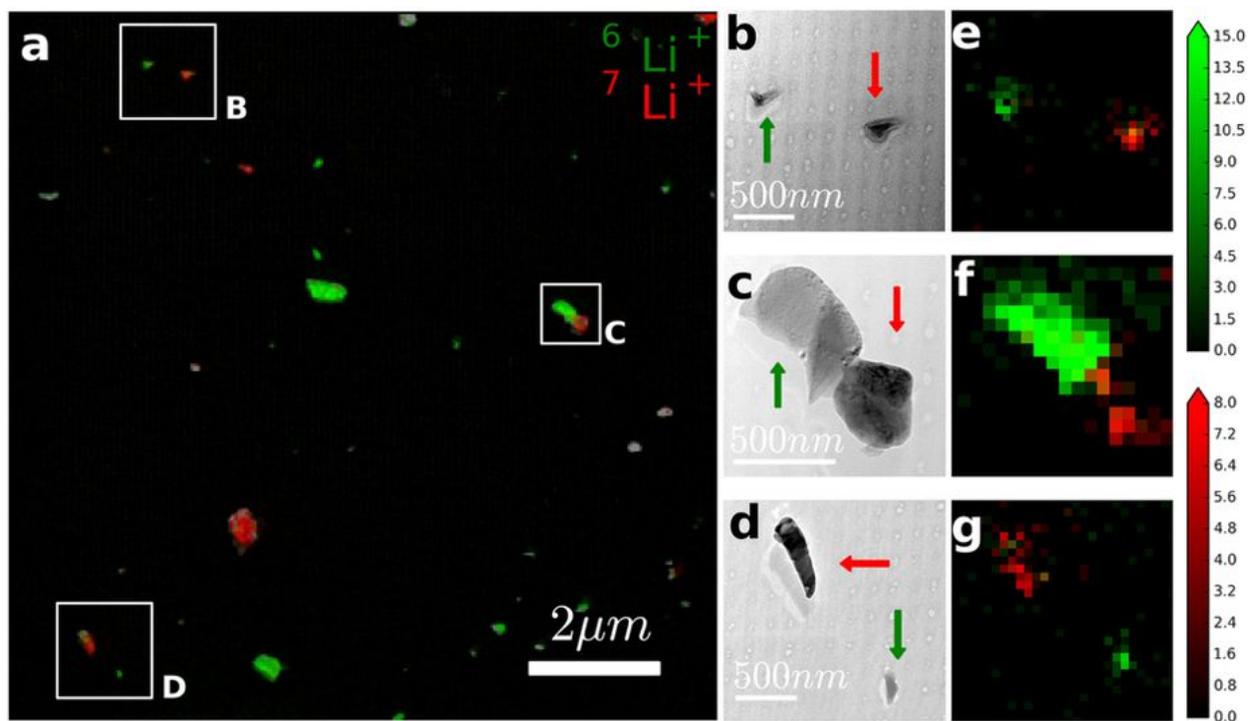


Figure 6. (A) PIES image: Overlay of BF-TEM image (contrast inverted) and SIMS images of ${}^6\text{Li}^+$ and ${}^7\text{Li}^+$, (B–D) high-magnification TEM images (contrast as acquired) corresponding to the boxed hotspots and (E–G) SIMS images of ${}^6\text{Li}^+$ (green) overlaid on ${}^7\text{Li}^+$ (red) corresponding to images B–D respectively. The arrows in the TEM images indicate nanoparticles rich in ${}^6\text{Li}^+$ (green) and ${}^7\text{Li}^+$ (red). The color scales indicate secondary ion counts in linear scale. Reproduced with permission from reference 92, under a Creative Commons Attribution 4.0 International License, Nature Publishing Group 2018.

Time-of-Flight Secondary Ion Mass Spectrometry (ToF-SIMS) is one of MSI techniques that uses a focused ion beam to release secondary ions from the surface and direct them into the time-of-flight analyzer to detect their mass-to-charge ratio. This tool requires high or ultra-high vacuum. The chemical spatial resolution in imaging mode for ToF-SIMS is defined by the spot size of the focused primary beam. Liquid metal ion guns, (LMIG) commonly used in static and dynamic SIMS, routinely provide ~ 100 nm spot sizes. The surface analysis can be complemented by additional sputtering sources, allowing the removal of significant amounts of the material. This extends chemical investigation into the bulk, down to few micrometers in depth. The time-of-flight mass analyzer used in ToF-SIMS offers mass resolution $m/\Delta m$ in the $\sim 10^3 - 10^4$ along with wide mass range (up to 10^5 Da) and high transmission efficiency (above 50%).⁹³ The time-of-flight approach also enables parallel acquisition of the chemical information on all chemical species seen by the detector.⁹⁴⁻⁹⁷ This produces high dimensionality datasets where an entire mass spectrum can

be recorded at each voxel of a 3-dimensional sample map; revealing the surface and bulk chemical composition of a material with sub-micrometer spatial resolution. ToF-SIMS has found its application in life sciences allowing to probe the distribution of relevant species within the biological sample (Figure 7).

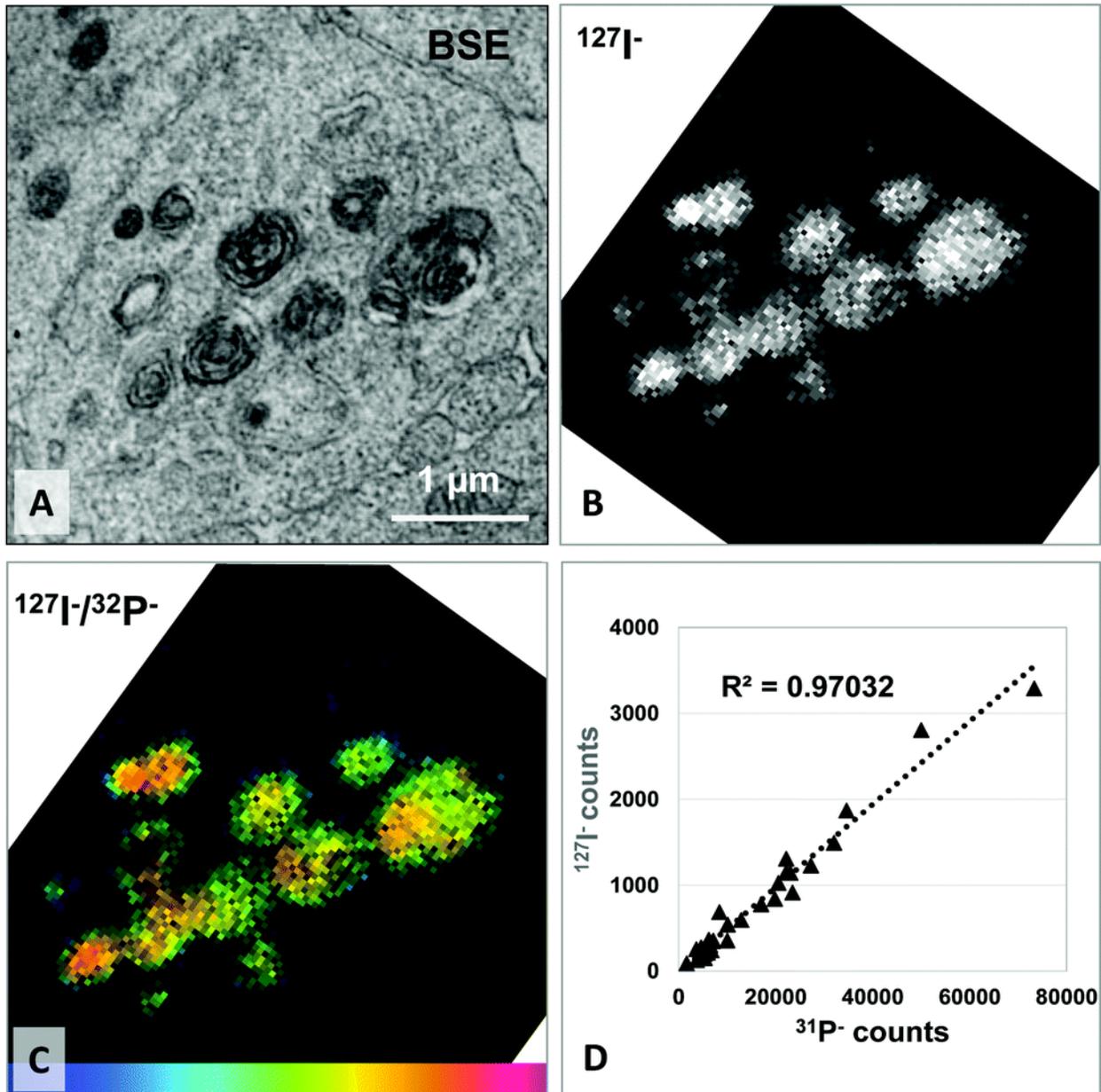


Figure 7. Correlative backscattered electron and nanoSIMS analysis of multilamellar lysosomes within amiodarone-treated macrophages; (A) BSE image zoomed on an area containing profound multilammellar lysosomes for the full image) and (B) the corresponding NanoSIMS $^{127}\text{I}^-$ secondary ion map, which shows the locations of amiodarone accumulation. (C) $^{127}\text{I}^-/^{31}\text{P}^-$ ratio image of the selected area (the ratio colour scale: 0–0.08, blue – pink, respectively).

(D) Plot of the $^{127}\text{I}^-$ and $^{31}\text{P}^-$ secondary ion intensities measured in lysosomes, showing a linear relationship between the amount of the drug and phospholipids accumulated in MLLs. Reproduced from reference 98, with permission of The Royal Society of Chemistry.

While there are obvious strengths to chemical sensitivity in the ToF-SIMS, its capabilities can be extended beyond chemical mapping by combining the tool with atomic force microscopy (AFM) in the same vacuum chamber. This multimodal imaging AFM/ToF-SIMS platform enables nanoscale characterization of chemical and physical properties of the sample along with the surface morphology. The chemical information acquired by ToF-SIMS, at chemical resolution of 50-100 nm can be supplemented with functional sample response measured by AFM at resolution down to 1 nm. This combination has been recently used by Sostarecz *et al.* to characterize chemistry and phase behavior of lipid films⁹⁹ and by Belianinov *et al.* to study ion induced changes in layered copper indium thiophosphate ferroelectrics.¹⁰⁰⁻¹⁰² Furthermore, a combined AFM/ToF-SIMS platform opens pathways for chemical characterization of local physical behavior at the nanoscale. In these types of experiments local chemical phenomena induced by the physical field of the AFM cantilever tip (including, but not limited to: mechanical, electric, thermal, magnetic, *etc.* excitation) can be studied by ToF-SIMS. Recently, this approach enabled a study focused on the growth of metal-organic frameworks with AFM tip grafting,¹⁰³ explore chemical phenomena associated with local polarization switching in ferroelectrics¹⁰⁴ (**Figure 8**), and investigate electrochemical response of lithium-ion cathodes¹⁰⁵ and chemical interaction between AFM tip and the sample surface.¹⁰⁶

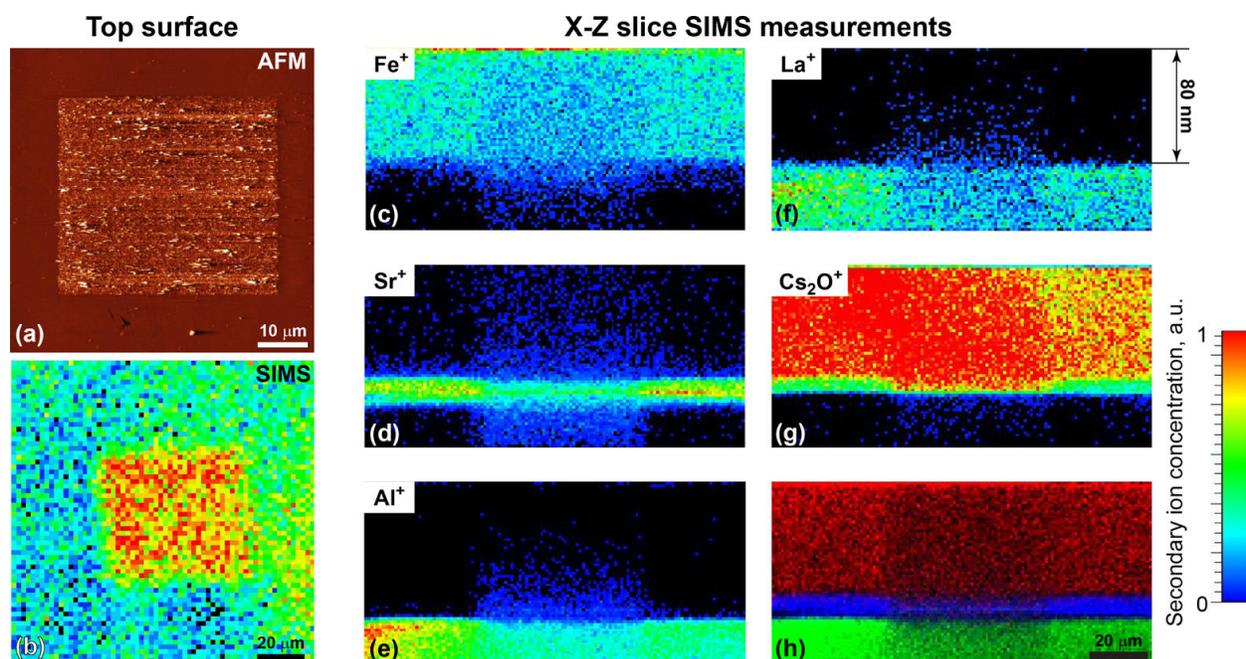


Figure 8. Combined AFM/ToF-SIMS investigations of the electro-resistive switching by AFM tip in BiFeO₃ thin film. (a) Topographical changes associated with electroresistive switching. (b) ToF-SIMS XY map of Bi⁺ on the surface. (c)-(g) XZ depth profiles across modified region, base elements of the BiFeO₃ film, SrRuO₃ buffer layer and LaAlO₃ substrate: (c) Fe⁺; (d) Sr⁺; (e) Al⁺; (f) La⁺; (g) Cs₂O⁺. (h) Overlay of Fe⁺ (red), Sr⁺ (blue) and Al⁺ (green). Reprinted with permission from reference 104, Ievlev, A. V.; Maksymovych, P.; Trassin, M.; Seidel, J.; Ramesh, R.; Kalinin, S. V.; Ovchinnikova, O. S., Chemical State Evolution in Ferroelectric Films During Tip-Induced Polarization and Electroresistive Switching. *ACS Appl. Mater. Interfaces* **2016**, *8*, 29588-29593. Copyright (2018) American Chemical Society.

AFM topography offers a quantitative roughness and depth measurements, which can be used before and after ion beam sputtering in 3D profiling ToF-SIMS measurements. In this type of work the depth of the sputtered crater as measured by AFM, allows sputter rate calibration and accurate volume reconstruction; assuming sample homogeneity.¹⁰⁷⁻¹¹⁰ The authors would like to point out that the chemical resolution is still dictated by the beam spot size. However, the geometric correction offered by the AFM topography can offer invaluable information at the data reconstruction step, where changes in morphology can significantly impact interpretation.¹¹¹⁻¹¹⁵

Thus, a combined AFM/ToF-SIMS platform offers a perfectly complimentary set of tools for correlated chemical and functional investigations of wide range of materials. Achieving lateral chemical spatial resolution below 50 nm with primary source LMIGs is still challenging. Gas field ion sources (GFIS) using helium, or neon ion beam as a primary source, combined with mass

spectrometer were recently suggested by Wirtz *et al.* and are based on commercially available helium ion microscope (HIM) Zeiss ORION NanoFab.¹¹⁶ While the source design for this tool is significantly more complex than for LMIG, the spatial resolution (~0.5 nm with He, and ~1.9 nm with Ne) is a significant breakthrough for the SIMS community.

Helium ion microscopy is a relatively young technique that can produce higher resolution images than scanning electron microscopy (SEM).^{117, 118} GFIS deliver high brightness ion beams and the interaction volume for helium ions is smaller than for electrons in SEM.¹¹⁹ The overall result is enhanced resolution and a greater depth of field for HIM compared to SEM.¹²⁰ In addition to the imaging of emitted secondary electrons, the helium ion beam can be used to obtain information on ions released by sputtering. High brightness, high current (5-10 pA) ion beams and a low energy spread below 1 eV can be theoretically focused to area smaller than 1 nm,¹²¹ making the GFIS interesting as a primary ion source for SIMS.¹²² No general restrictions exist that prohibit the use of gases other than helium in GFIS, although practical reasons limit the use to species with sufficiently high ionization energies, *i.e.*, to helium and neon.¹²³

While the small focus size of the GFIS beam directly translates into a higher spatial resolution, for SEM the limitations for the analysis of secondary ions are set by the lateral dimensions of the collision cascades induced in the sample. For helium, the collision cascade is situated quite deep below the sample surface but because only a small fraction of the impact energy is deposited close to the surface, sputter yields (the fraction of sputtered particles to incident ions) are low (<1 for He¹¹). For neon, the surface area that secondary particles are sputtered is significantly larger due to shallower collision cascades.^{124, 125} Sputter yields are higher (30× in comparison to He) and comparable to O and Cs ion beams routinely utilized in SIMS.

The initial work of Wirtz *et al.*¹¹⁶ led to the development of a HIM-SIMS tool based on the Zeiss ORION NanoFab microscope utilizing a custom set of retractable extraction optics to feed into a double focusing magnetic sector mass spectrometer with 4 detectors in a Mattauch-Herzog design. This system showed chemical imaging with 13 nm lateral resolution on a standard sample. Another implementation of HIM-SIMS platform was demonstrated by Klingner *et al.* extended a Zeiss ORION NanoFab by time-of-flight based mass analyzer with a pulsed primary ion beam and a multi-channel plate (MCP) based ion detector.¹²⁶ Altogether HIM-SIMS is considered as a

perspective direction of development for MSI, allowing chemical imaging with ultimate spatial resolution.

Although, various SIMS techniques provide great set of the tools for chemical imaging with sub-micrometer and even nanometer spatial resolutions, several fundamental problems hamper its application for identification of large (biological) molecules. Primary ion beams used in SIMS for ionization lead to molecular fragmentation. Furthermore, SIMS measurements require vacuum, which is not compatible with many materials. This significantly complicates chemical characterization of biological and some other systems in SIMS. Hybrid solution, utilizing sharp AFM tips for material desorption from the surface of the sample have been recently suggested.¹²⁷⁻

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An AFM tip can be used to mechanically uptake sample material from the surface. The work by Lee *et al.*¹²⁸ suggested using field ionization to release the scratched material into a mass spectrometer for elemental analysis. The entire SPM – MS system was held under vacuum along with a special probe design that enabled tip transfer (together with the collected sample) from a surface sampling position to a field desorption emitter position. In other work by Hoffmann *et al.*¹³⁰ the AFM tip was used to mechanically sample material from the surface, with a subsequent temperature ramping step for the controlled release of the material by thermal desorption. Initial work on coupling direct thermal desorption from the sample surface with heated AFM cantilever probes with mass spectrometry has been developed by Price *et al.*¹³¹ This method used an offline approach to capture material that was thermally desorbed under either volatilization or pyrolysis on a sorbent in close vicinity to the desorption site. This enabled the analysis of the desorbed material by gas chromatography coupled with mass spectrometry. Other researchers also used similar approaches to draw material from the desorption site through a capillary into a separate collection device for the deposition onto graphite which allowed for subsequent laser desorption and 2-photon ionization.¹³²

Several combined AFM/MS platforms using thermal desorption have been developed. Their general applicability has been illustrated for small organic molecules including dyes, pharmaceuticals, explosives and pesticides.¹³³⁻¹³⁵ The application to polymers also has been shown (**Figure 9**), based on the detection of small characteristic fragments—such as for poly(methyl methacrylate) (PMMA), polystyrene (PS), poly(2-vinylpyridine) (P2VP).¹³⁶⁻¹³⁸ The overall

sensitivity of the combined AFM/MS platform can be benchmarked by the minimal detectable amount of sample material (*e.g.*, the smallest desorption crater) and future developments are focused on improving the precision with which the material is removed.

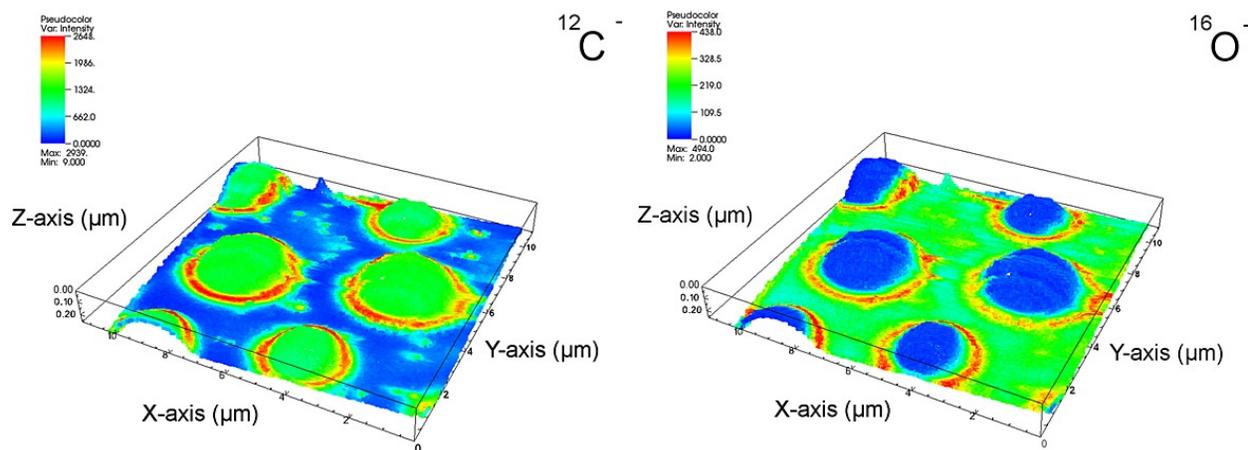


Figure 9. Combined SIMS-SPM 3D mapping of a PS/PMMA blend. Field of view: $10.6 \times 9.8 \mu\text{m}^2$. Reproduced with permission from reference 139 Wirtz, T.; Fleming, Y.; Gysin, U.; Glatzel, T.; Wegmann, U.; Meyer, E.; Maier, U.; Rychen, J., Combined Sims-Spm Instrument for High Sensitivity and High-Resolution Elemental 3d Analysis. *Surf. Interface Anal.* **2013**, *45*, 513-516. Copyright John Wiley & Sons, Inc 2018.

In the case of thermal desorption, improved heating functions can reduce the redeposition of initially desorbed material¹⁴⁰ on the vacuum transfer line walls.¹⁴¹ Additionally, inline ion sources can aid with material ionization for lower limits of detection. For example, AFM coupled to a custom built electrospray ionization (ESI) stage is capable of detecting 250 nm craters in pure caffeine.¹²⁹ Several implementations using atmospheric pressure chemical ionization (APCI) stages have been used, based on a modifications of the manufacturer's ion source design¹³³ and custom APCI based inline ionization stages.^{136, 141} Detection of ink dye components for spot-sampling yields 800 nm lateral resolution, as well as 411 nm spatial resolution for P2VP and polystyrene PS polymers. For the multimodal imaging with an AFM/MS system, Ovchinnikova *et al.* illustrated a phase-separated PS/P2VP system using multiple imaging modalities provided by the AFM (topography and band excitation nanomechanical), followed by the chemical imaging of thermally desorbed material in the MS (**Figure 10**).¹⁴²

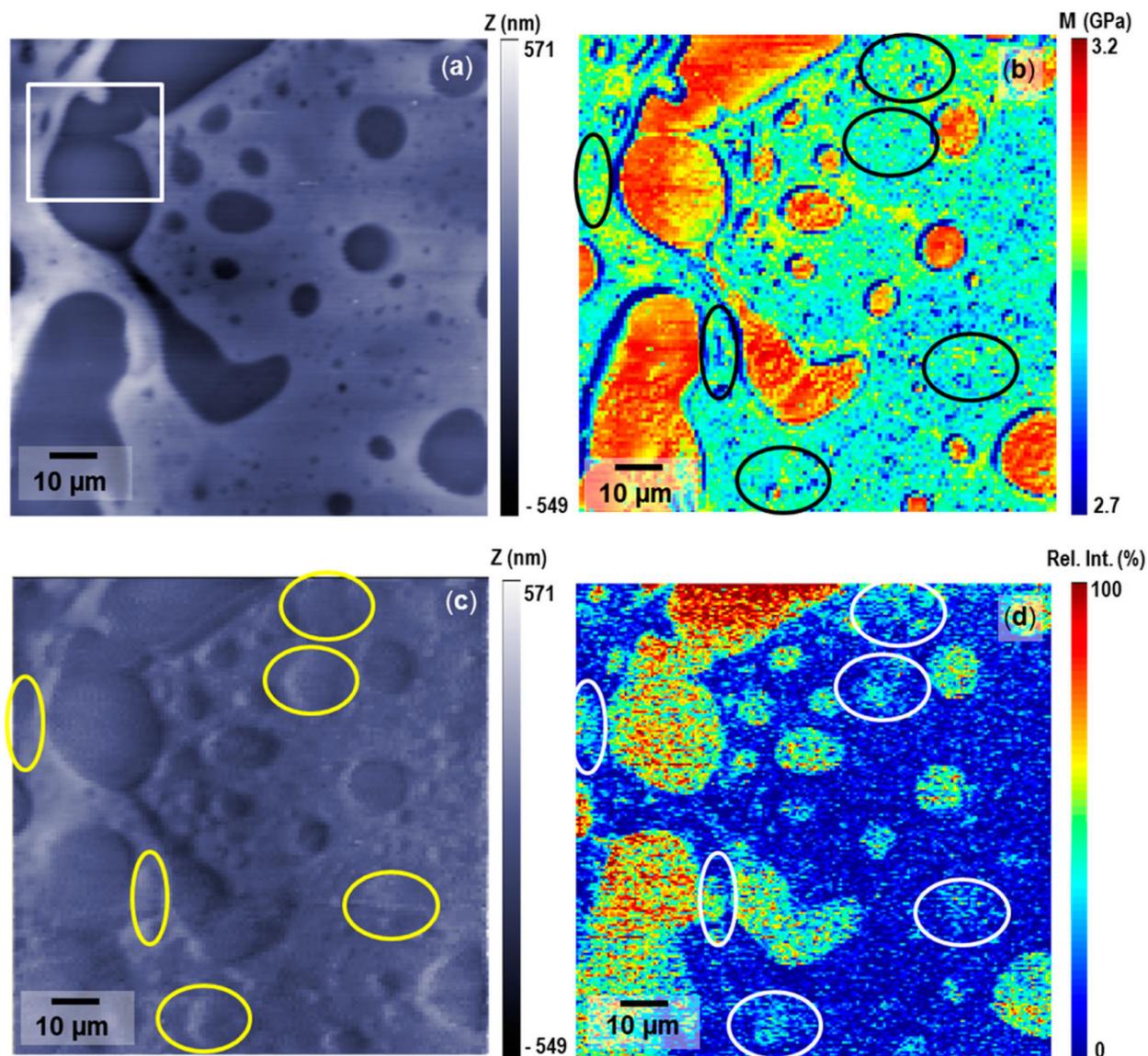


Figure 10. Co-registered AFM (a) pre-pyrolysis topography image, (b) BE elastic modulus image, (c) post-pyrolysis topography image, and (d) mass spectrometry chemical image for m/z 106, obtained from an ~ 500 nm thick thin film of phase-separated PS/P2VP blend. The color scale for the topography goes from dark to light, which is proportional to an increase in relative surface height. Highlighted ovals in panels (b), (c), and (d) indicate areas where the AFM topography, elastic modulus, and mass spectrometry images differ in terms of the presence of P2VP. Reprinted with permission from reference 142 Ovchinnikova, O. S.; Tai, T. M.; Bocharova, V.; Okatan, M. B.; Belianinov, A.; Kertesz, V.; Jesse, S.; Van Berkell, G. J., Co-Registered Topographical, Band Excitation Nanomechanical, and Mass Spectral Imaging Using a Combined Atomic Force Microscopy/Mass Spectrometry Platform. *ACS Nano* **2015**, *9*, 4260-4269. Copyright (2018) American Chemical Society.

In summary, multimodal platforms where mass spectrometry imaging is combined with other scanning probe microscopy techniques allows a significant extension of capabilities for chemical

characterization and correlation of chemical phenomena with structural and physical properties. In addition to classical optics, and scanning probe systems incorporated into combinatorial MS systems, tools featuring nonlinear optical microscopy components are gaining popularity.

Nonlinear Optical Microscopy

Nonlinear optical spectroscopies have now been used for several decades to probe chemical and physical phenomena in systems spanning small molecules,¹⁴³⁻¹⁴⁵ proteins,¹⁴⁶⁻¹⁴⁸ complex materials,¹⁴⁹⁻¹⁵¹ and interfaces.¹⁵²⁻¹⁵⁵ The foundation of any nonlinear method lies in multiple interactions between the sample and the incident radiation driven by the high intensity of a laser that is often pulsed. It is through these multiple light-matter interactions that access to ultrafast dynamics, or surface selective chemistry, which are not available using linear optical methods, is obtained. These methods thereby provide a direct view of the underlying physical and/or chemical processes at play. Despite the great advances in fundamental understanding, traditionally ensemble spectroscopic probes report spatially averaged information. In many cases however, heterogeneity on the nano- and mesoscales is critical to the function and performance of these sample systems. As such, there has been a push to apply nonlinear optical methods to microscopic platforms to obtain both chemically selective and time-resolved information from spatially heterogeneous and chemically complex samples. By far, the most common form of nonlinear microscopy is two-photon fluorescence microscopy, which has found greatest utility in biological imaging applications.¹⁵⁶⁻¹⁵⁹ This technique takes advantage of two-photon transitions to populate an electronic excited state from which a photon is emitted and recorded at a given spatial location. This approach is the nonlinear analog of confocal fluorescence microscopy, but boasts superior penetrating power, reduced photobleaching, and intrinsic longitudinal sectioning.¹⁵⁶⁻¹⁵⁸ These methods tend to rely on an assortment of stains/dyes that are designed to target specific regions of a system,^{160, 161} say in a cellular membrane,¹⁶² and thus provide contrast based on where the labels are localized and can emit light. These approaches have also found utility in imaging domains and local ordering in light harvesting materials without the need for labels.¹⁶³ While widely used, these methods rely on the emission of light, which in many cases necessitates staining procedures or the study of materials with appreciable quantum yields, thereby limiting the overall utility. To address these limitations, complimentary suites of nonlinear optical microscopies have been developed to

probe native species in complex heterogeneous samples without the need for chemical labels or dyes. These can be categorized as even-order techniques that are sensitive to the molecules at an interfacial monolayer or to chiral assemblies of molecules- *e.g.*, Second Harmonic Generation (SHG)^{92, 164-170} and Sum-frequency Generation (SFG),^{101, 171-175} and odd-ordered methods that probe molecular resonances in the bulk material - *e.g.*, Coherent Anti-Stokes Raman Scattering (CARS),¹⁷⁶⁻¹⁷⁹ Stimulated Raman Scattering (SRS),^{180, 181} and Transient Absorption Microscopy (TAM).¹⁸²⁻¹⁸⁸ Note that this is not an exhaustive list but is rather a compilation of those most commonly found in the literature.

As an example, both CARS and SRS microscopies have revolutionized the way in which vibrational chemical images are taken. Traditional linear Raman microscopes rely on a weak Raman scattering process, which limits the time and fidelity at which a chemical map can be obtained. In contrast, using coherent nonlinear approaches, Raman signals can be greatly enhanced allowing for chemical images to be obtained at video rate,^{180, 181} or for the dynamics of a single molecules tracked in time.¹⁷⁷ SHG imaging methods have been developed and applied to probe interfacial or chiral species.^{92, 164-170} Due to symmetry considerations, only species in non-centrosymmetric environments (*i.e.*, interfaces) or chiral species can produce appreciable SHG signals, thus making it an ideal tool for imaging interfacial phenomena and biological systems. Through staining procedures, SHG methods can provide insight in local electric fields complex systems such as neurons.^{165, 166} Extension of SHG imaging to SFG microscopy has been reported in a several different geometries with samples studied ranging from biological systems to complex materials.^{101, 171-175} Of particular note, is the recent development of compressive sensing SFG microscopy, which leverages efficient means to acquisition hyperspectral images with relatively minor modifications to a conventional SFG spectrometer.^{172, 173} It is expected that approaches using compressive sensing will revolutionize the field of nonlinear microscopy by allowing chemical images to be obtained using established spectroscopic protocols, while providing microscopic insight.

In parallel, approaches using intrinsic time-domain responses as a source of chemical contrast have appeared in the literature.¹⁸⁸⁻¹⁹⁴ These approaches extend Fluorescence Lifetime Imaging Microscopy (FLIM) techniques,¹⁹⁵ where the temporal responses of excited states species can provide contrast between areas of disparate chemical speciation or environments while

simultaneously providing access to excited state photochemical dynamics. A distinguishing feature of transient absorption microscopies (also known as pump-probe microscopy¹⁹²) is the use of multiple laser pulses to excite and probe species at controllable ultrafast (fs-ps) time delays to produce a 3D-image stack as shown in **Figure 11**. By exciting and probing the system at very early time delays, access to a whole realm of information is obtained, including the dynamics of excitons, motions of charge carriers, and local chemical makeup, to name a few examples. Additionally, since the probe pulse carries the relevant optical signals, one does not rely on emission of the sample thus allowing for native non-fluorescent samples to be imaged¹⁸⁸ at sub-diffraction limited spatial resolutions with sub 100 fs temporal resolutions.

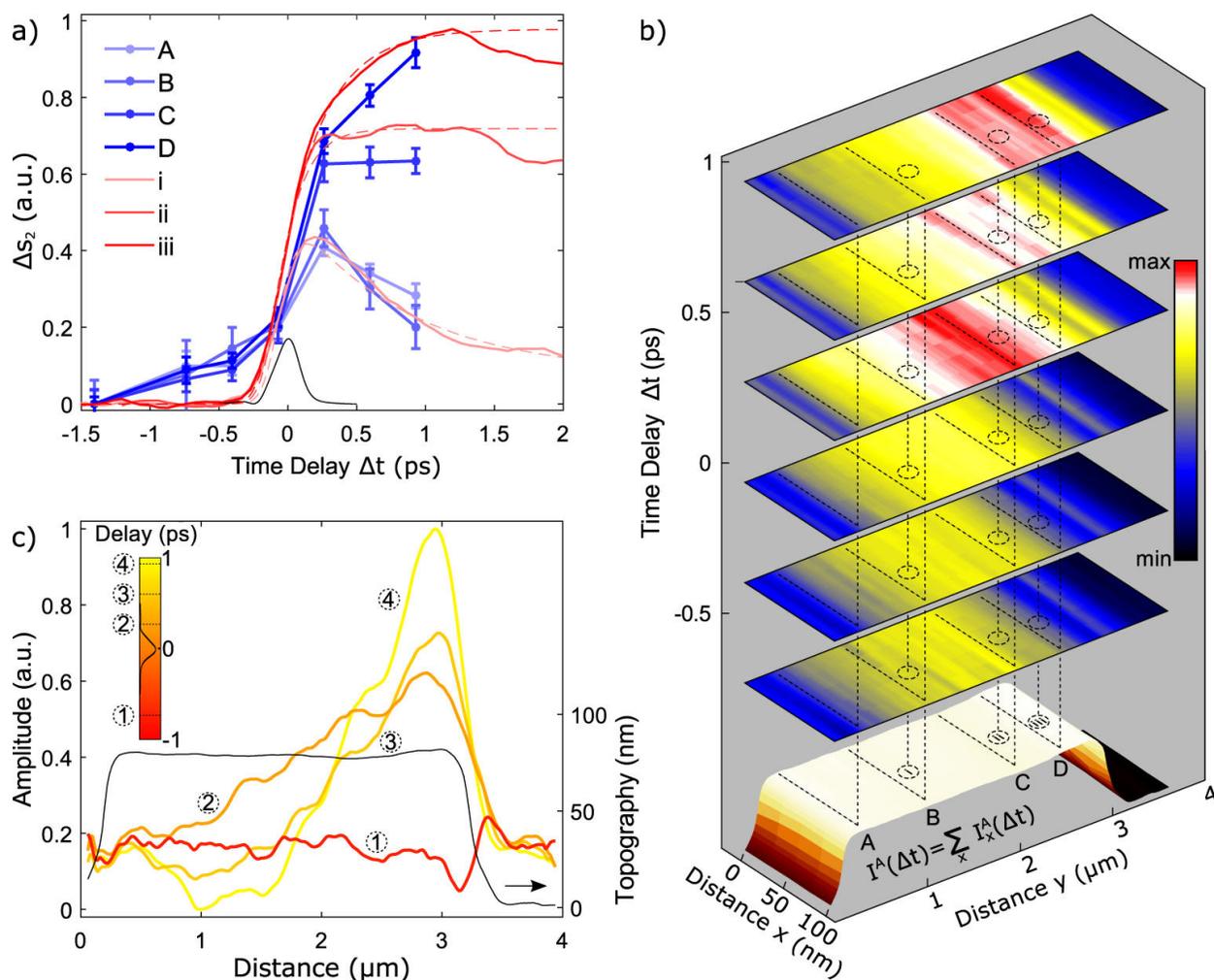


Figure 11. (a) Near-field pump-probe time traces recorded on different positions on a microcrystal (red, positions indicated in panel b), together with full time traces extracted from a series of spatiotemporal images (blue, images and positions shown in panel b). (b) Set of images showing spatial and temporal variations in the IMT dynamics of a single VO₂ microcrystal. (c) Line profiles for several pump-probe time delays across the microcrystal shown in panel b.

Reprinted with permission from reference 196, Donges, S. A.; Khatib, O.; O'Callahan, B. T.; Atkin, J. M.; Park, J. H.; Cobden, D.; Raschke, M. B., Ultrafast Nanoimaging of the Photoinduced Phase Transition Dynamics in VO_2 . *Nano Lett.* 2016, 16, 3029-3035. Copyright (2018) American Chemical Society.

Pioneering work by the Warren group demonstrated this capability through selective probing and characterization of cancerous tissues.^{193, 194} By selectively exciting species and probing the ultrafast dynamics in time, they were able to differentiate between species having indistinguishable absorption spectra by using only the ultrafast responses. In this way they were able to spatially localize the distributions of eumelanin and pheomelanin in skin lesions without chemical labels.¹⁹⁴ These approaches have even been applied to fine art, in the characterization of pigments in paintings in a non-destructive manner.¹⁹⁷ TAM has also found numerous applications to materials systems where insight into photophysical phenomena in spatially heterogeneous materials is generally lacking. For instance, work probing lead halide perovskites, also extensively studied by scanning probes¹⁹⁸⁻²⁰¹, used the temporal response at distinct spatial locations to characterize the photoexcited state species that were created (**Figure 12**)¹⁹¹ This, and related work, demonstrated that a coexistence of charge carriers and excitons is present in these materials.¹⁸⁹⁻¹⁹¹ Other examples of the utility of TAM based microscopies make use of spatially offset probe pulses^{185, 202, 203} to track the motions of carriers as they move through a material in space and time. This powerful approach provides a movie of excited state processes evolving on native time and length scales, which holds promise in understanding photo physics in spatially heterogeneous and chemically complex materials.

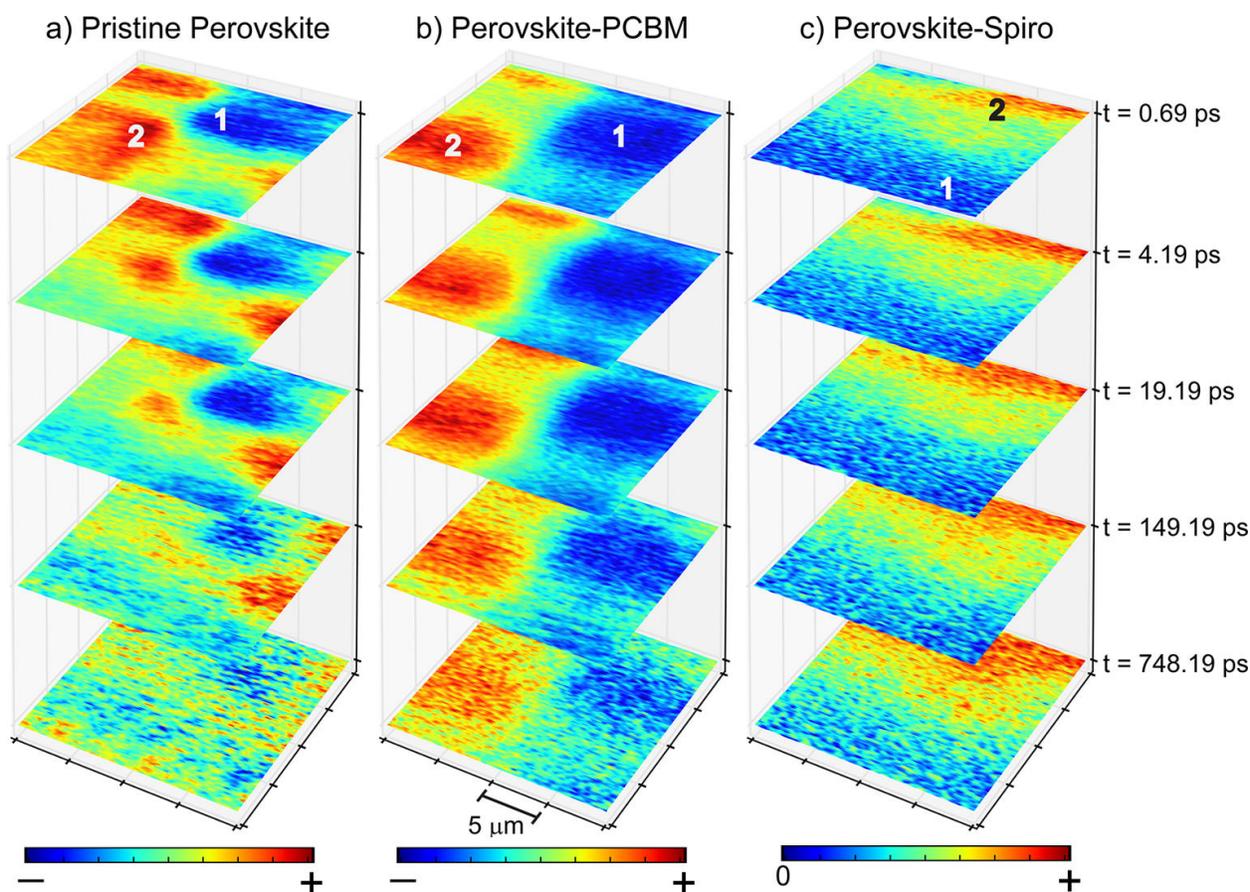


Figure 12. TAM images acquired for the same area of the pristine $\text{CH}_3\text{NH}_3\text{PbI}_3$ (a), $\text{CH}_3\text{NH}_3\text{PbI}_3/\text{PCBM}$ (b), and $\text{CH}_3\text{NH}_3\text{PbI}_3/\text{Spiro-OMeTAD}$ (c) samples at five different delay time delays. Scale bars are $5\ \mu\text{m}$. The color bars encode the variation in TAM signal and sign. Adapted with permission from 204, Simpson, M. J.; Doughty, B.; Yang, B.; Xiao, K.; Ma, Y. Z., Spatial Localization of Excitons and Charge Carriers in Hybrid Perovskite Thin Films. *J. Phys. Chem. Lett.* 2015, 6, 3041-3047. Copyright (2018) American Chemical Society.

While TAM methods provide excellent sensitivity to ultrafast electronic processes, it is morphologically blind. This lack of morphological information can limit interpretations regarding photophysical processes based on challenges in correlating material structure to emission intensities or TAM images collected on different platforms. To circumvent this, multimodal approaches to TAM have been developed by combining linear photoluminescence (PL),²⁰⁵ transmission, and confocal reflectance microscopies into a single platform.²⁰⁶ By collecting a multidimensional dataset using the same laser system at the same sample location, insight into how morphology and film thickness impact the ultrafast and exit channel dynamics (TAM and PL imaging, respectively) can be obtained. For instance, from a correlation analysis of four different optical modalities, it was shown that in mixed perovskite thin films PL originates predominantly

from the first few layers of the film, whereas the TAM measurements probe predominantly bulk excited state processes.²⁰⁶

Through the combination of the various linear and nonlinear optical methods described above that use the same microscopic platform a more complete picture of the sample can be obtained than using any individual approach. That being said, challenges in processing and developing physical insight these large multidimensional datasets, often with different resolutions, bin sizes, *etc.*..., exist and remain to be addressed as chemical imaging methods continue to grow. Coupling of these optical methods to scanning probe^{207, 208} or electron microscopy methods^{209, 210} has also attracted attention and remains an avenue for continued development. For instance, using near-field optical excitation for the probing the sample for the visualization and spectroscopic characterization of a vast variety of nano materials, from semiconducting nanoparticles to polymer thin films to sensitive measurements of single molecules (**Figure 13**). In addition, it can be conducted in non-contact mode, producing high-resolution measurements at ambient conditions. Such non-linear optical properties of materials as nonlinear excited state absorption and stimulated Raman vibrational transitions can be locally measured by these approaches. The ultimate goal would be to push the temporal and spatial limits of both optical and scanning probe/electron microscopy methods to address scientific questions at the extremes of space and time.

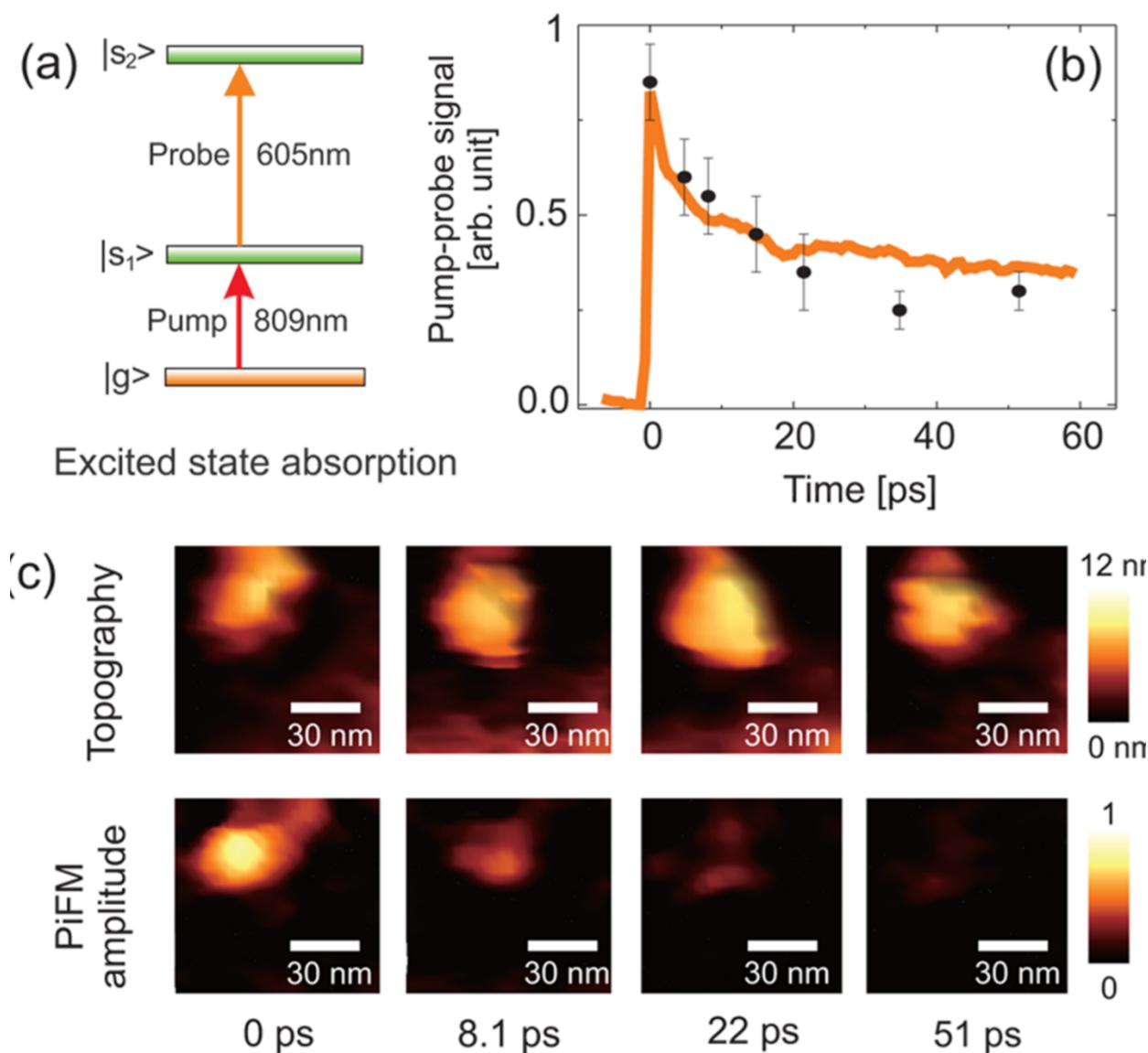


Figure 13. (a) Schematic of the pump–probe excitation of SiNc. (b) Time-resolved excited state absorption measured with PiFM (solid dots) and with optical pump–probe microscopy (solid line). (c) Topography (top) and PiFM signal amplitude (bottom) of a nanocluster measured at different time delay settings of the probe pulse. Reprinted with permission from reference 211, Jahng, J.; Fishman, D. A.; Park, S.; Nowak, D. B.; Morrison, W. A.; Wickramasinghe, H. K.; Potma, E. O., *Linear and Nonlinear Optical Spectroscopy at the Nanoscale with Photoinduced Force Microscopy*. *Acc. Chem. Res.* **2015**, *48*, 2671-2679. Copyright (2018) American Chemical Society.

Multimodal and multidimensional data analysis

Over the last two decades, developments in the characterization equipment have significantly increased the size and the quality of data produced by experimental techniques.²¹²⁻²¹⁷ Improved detectors, a rise in multimodal tools – machines capable of probing different material properties, and clever uses of metadata have underwritten the growth of collected and stored data. Interestingly, this trend in scientific data growth follows classification devised by IBM in 2012²¹⁸ for big data on the web, shown in **Figure 14**, and is reflected in a wide variety of common characterization techniques, *e.g.* scanning probe microscopy; with data volumes and computational complexity reflected in **Figure 14(b, c)**, as well as scanning transmission electron microscopy, mass spectrometry, and many others. Terabytes of scientific data in biological and material sciences are now common beyond monolithic tools like accelerators and beam lines; the data is mixed between structured and unstructured, and many detectors and devices are moving to storing data streams as opposed to data batches. Unfortunately, analysis approaches have largely lagged behind this growth, or remained static altogether.^{219, 220}

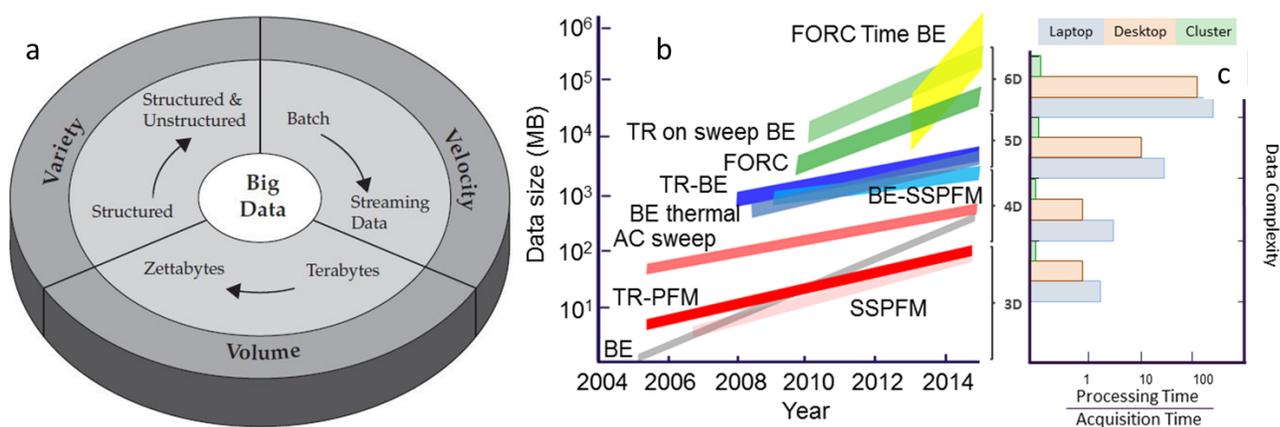


Figure 14. Data set size and computational power evolution. (a) IBM’s characterization of Big Data – Volume, Variety, Velocity, or V3. (b) Evolution of multidimensional data sets in scanning probe microscopy and their sizes over the last decade. Acronym list: BE, band excitation; SSPFM, switching spectroscopy piezoresponse force microscopy; TR PFM, time resolved piezoresponse force microscopy; BE SSPFM, band excitation piezoresponse force microscopy; TR BE, time resolved band excitation; FORC, first-order reversal curve. (c) Typical processing/acquisition time (smaller value is better) on a laptop, desktop, and cluster for multidimensional data sets. Hardware configurations were assumed as follows: laptop - 4-core processor, 8 GB of RAM, integrated video, and 1 hard drive approximately 1 TB of space; desktop - 12-core processor, 32 GB RAM, dedicated video, 2 hard drives, 4 TB of space; cluster - 10 nodes, each node with 8 processors at 8 cores, 20 GB of RAM, 160 GB storage space. Adopted with permission from 221, under an Open Access article distributed under the terms of the Creative Commons Attribution License. Copyright Springer 2018.

Advances in machine learning brought significant developments to multiple areas of science and engineering, specifically image processing,²²² with perhaps autonomous vehicle technology leading the charge.²²³ While the aspects of image processing and machine learning have already begun appearing in areas of microscopy,²²⁴⁻²²⁷ the underpinning aspects of what makes machine learning so attractive to scientists is the ability to make sense of seemingly disconnected pieces of data; potentially coming from a wide variety of sources, at various rates, resolutions, and reflective of different material properties.²²⁸

This is promising for chemical imaging, where many of the collected data, or data descriptors, contain correlated information on structure and property of the specimen. While the analysis of these data has traditionally followed a qualitative and manual approach, the veracity and volume of data produced by modern multimodal instrumentation either preclude such methods, or significantly hampers the processing rate. Nonetheless, manual, or semi-automated approaches have proven to be successful in relatively high-volume data environments combining multimodal information to present a fuller picture of material composition and exhibited properties.^{142, 229-232} More advanced approaches, leveraging deep learning, are less common, but are now gaining popularity.²³³⁻²³⁵ Nevertheless, the penetration of machine learning into scientific and industrial areas reliant on multimodal tools, and combinatorial data approaches remain slow. In addition, machine learning enables high-throughput processing of experimental data from multiple sources through the data fusion (**Figure 15**). This approach boosts the capability to generate complex insights about composition and structure of the sample by improving the quality of the image as well as deriving connections between various sample properties on a fundamental level.

This trend reflects several challenges complicating direct adaptability of data analytics to multimodal problems in science and engineering. While many in their respective fields have achieved a considerable degree of sophistication in the use of respective experimental, theoretical and computational tools, the overlap between these communities is small. This problem is exacerbated by a lack of a common language and philosophy and will likely necessitate extensive cross-disciplinary training. Furthermore, big- and deep-data approaches, implying knowledge extraction from data, greatly benefit from universal, centralized, or distributed databases and repositories. This requires information exchange between researchers, requiring the development of infrastructure, adoption of compatible and potentially universal data formats, and addressing

inevitable intellectual property and socio-cultural issues. Private entities like Citrine Informatics, have already begun to fill these gaps proving that there is a viable pathway towards centralizing and standardizing scientific information.

Perhaps the most compelling evidence for feasibility of large-scale processing and machine learning in science and engineering comes from areas that have long embraced the potential of these tools and have shown their practicality. Data analytics have been long established in the materials modelling community, starting with chemometrics and on to computation and correlation of response functions with experimental data. In fact, the argument could be made that rapid advances in quantum density functional theory, was a grassroots moment for the concept of computational-based materials by design.²³⁶ Early efforts that utilized the power of supervised and unsupervised neural networks, genetic and evolutionary algorithms, along with graph theory and statistics-based methods demonstrated capabilities, even though the data available at that time was modest compared with the volumes accessible today.^{237, 238} These success stories, advances in experimental techniques, and availability of high-quality information, as well as notable advances in high-performance computing,²³⁹ offer a clear roadmap to the required capabilities for better scientific data analysis and bridge technologies across various disciplines.

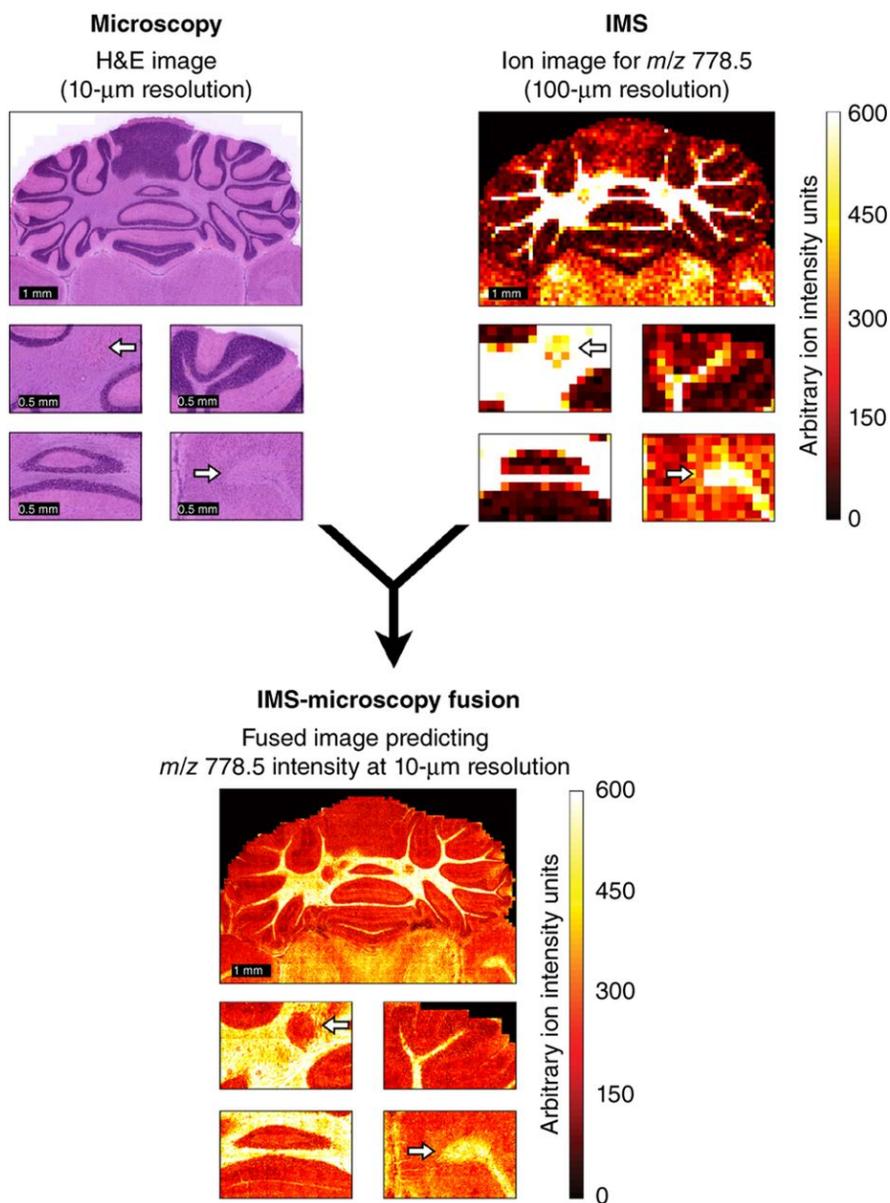


Figure 15. An ion image measured in mouse brain, describing the distribution of m/z 778.5 (identified as lipid PE(P-40:4)) at 100- μm spatial resolution (top right), is integrated with an H&E microscopy image measured from the same tissue sample at 10- μm resolution (top left). By combining the information from both image types, the image fusion process can predict the ion distribution of m/z 778.5 at 10- μm resolution (bottom). Reprinted by permission from Springer Nature reference 240, Van de Plas, R.; Yang, J.; Spraggins, J.; Caprioli, R. M., Image Fusion of Mass Spectrometry and Microscopy: A Multimodality Paradigm for Molecular Tissue Mapping. *Nature methods* 2015, 12, 366. Copyright Nature Methods 2018.

Conclusions

Chemical analysis at the nanoscale is critical to progress in the fields of biology, medicine, and material science. Complicated processes like cellular signal transduction, pharmaceutical discovery, and trace element characterization in nanoelectronics, require nanometer-resolved multimodal chemical and physical analysis. This subsequently drives the need for analytical tools offering higher sensitivity, and detailed chemical information coupled to high spatial resolution modes. The trend is beginning to be recognized by equipment manufacturers and is evidenced by the development of several platforms. Much attention has been focused on combining chemically sensitive techniques with high spatial resolution techniques such as scanning probes, optical microscopy, and electron/ion systems. Developing multimodal imaging approaches and interrogating multiple properties on a single platform circumvents many technical issues associated with sample preparation, transfer and storage. Furthermore, these combinatorial techniques generate multidimensional data sets, which are expected to grow; and contain data as a function of constantly increasing number of parameters such as time, temperature, bias, light and other external *stimuli*. From the technical aspect moving towards single platforms can significantly reduce the complexity associated with intermediary data processing and visualization steps, as well as data provenance. Effective approaches to dimensionality reduction, scalable algorithms, high performance computing, and cloud infrastructure still need to be widely and uniformly implemented for scientific use. Nonetheless, multimodal chemical imaging systems already offer a glimpse of powerful capabilities offered by extracting additional information from cross correlating and combinatorial processing of the captured material signals. Going forward we will without a doubt see an emergence of more complex processing capabilities (likely through the use of support vector machines and supervised learning methods) as well as significant breakthroughs in multimodal hardware capable of capturing even more independent channels of information.

Acknowledgements: The research conducted by A. B., A. V. I., N. B., S. K. and O. S. O. was sponsored by the Center for Nanophase Materials Sciences, which is a DOE Office of Science User Facility. The research for B.D. and M. L. was sponsored by the Laboratory Directed Research and Development Program of Oak Ridge National Laboratory, managed by UT-Battelle, LLC, for

the U.S. Department of Energy. B.D. would like to acknowledge useful conversations with Tessa R. Calhoun.

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